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DMG7702SFG

30V N-CHANNEL ENHANCEMENT MODE MOSFET WITH SCHOTTKY DIODE PowerDI3333-8

Product Summary

V _{(BR)DSS}	R _{DS(ON)}	Package	I_{D} $T_{A} = +25^{\circ}C$
30V	10mΩ @ V _{GS} = 10V	PowerDI [®] 3333-8	12A
307	15mΩ @ V _{GS} = 4.5V	PowerDI 3333-8	9.5A

Description

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

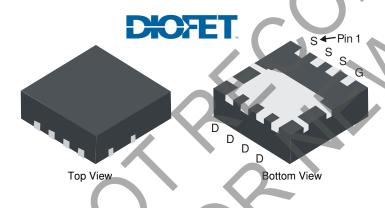
- Backlighting
- Power Management Functions
- DC-DC Converters

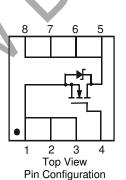
Features

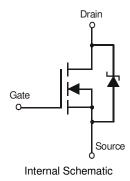
- DIOFET utilizes a unique patented process to monolithically integrate a MOSFET and a Schottky in a single die to deliver:
 - Low R_{DS(ON)} minimize conduction losses
 - Low V_{SD} reducing the losses due to body diode conduction
 - Low Q_{rr} lower Q_{rr} of the integrated Schottky reduces body diode switching losses
 - Low gate capacitance (Q_g/Q_{gs}) ratio reduces risk of shootthrough or cross conduction currents at high frequencies
- Small form factor thermally efficient package enables higher density end products
- Occupies just 33% of the board area occupied by SO-8 enabling smaller end product
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: PowerDI3333-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Pating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe.
 Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.072 grams (approximate)







Ordering Information (Note 4)

Notes:

Part Number	Case	Packaging
Fait Nullibei	Case	rackayiliy
DMG7702SFG-7	PowerDI3333-8	2000/Tape & Reel
DMG7702SFG-13	PowerDI3333-8	3000/Tape & Reel

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/



DMG7702SFG

Marking Information



G72 = Product Type Marking Code YYWW = Date Code Marking YY = Last Two Digits of Year (ex: 11 = 2011) WW = Week Code (01 to 53)

Maximum Ratings (@ $T_A = +25$ °C, unless otherwise specified.)

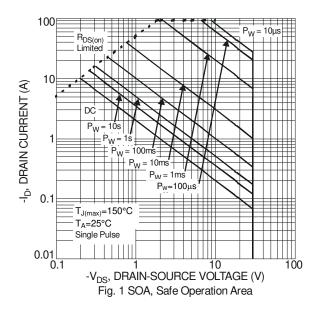
Characteristic	Symbol	Value	Unit		
Drain-Source Voltage	V_{DSS}	30	V		
Gate-Source Voltage	V _{GSS}	±20	V		
Continuous Drain Current (Note 6) V _{GS} = 10V	Steady State	$T_A = +25$ °C $T_A = +70$ °C	l _D	12 9.5	А
Continuous Drain Curient (Note 6) VGS = 10V	t<10s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	٥	16.0 12.7	A
Continuous Drain Current (Note C) V 45V	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	9.5 7.5	A
Continuous Drain Current (Note 6) V _{GS} = 4.5V	t<10s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	13.0 10.3	Α
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I _{DM}	90	Α		
Maximum Continuous Body Diode Forward Current (N	ls	3.5	Α		
Avalanche Current (Note 7) L = 0.1mH			I _{AR}	17	Α
Repetitive Avalanche Energy (Note 7) L = 0.1mH			EAR	43	mJ

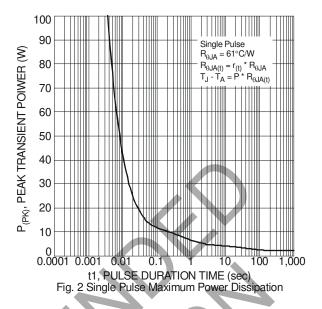
Thermal Characteristics

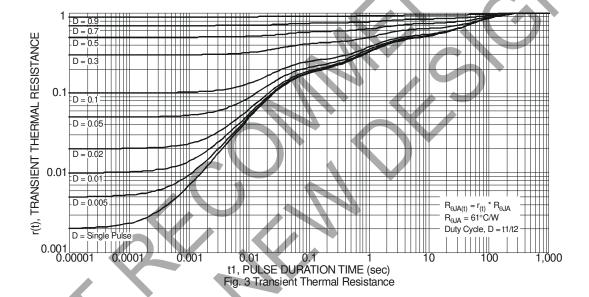
Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	$T_A = +25^{\circ}C$	D	0.89	W
Total Fower Dissipation (Note 5)	$T_A = +70$ °C	P_{D}	0.55	
Thermal Resistance, Junction to Ambient (Note 5)		J	145	°C/W
Thermal nesistance, Junction to Ambient (Note 3)	t<10s	$R_{ hetaJA}$	74	G/VV
Tatal Davier Discinction (Note C)		р	2.2	W
Total Power Dissipation (Note 6)	$T_A = +70$ °C	P _D	1.3	۷V
Thermal Resistance, Junction to Ambient (Note 6)		$R_{ heta JA}$	58	°C/W
Thermal nesistance, sufficient to Ambient (Note 6)	31			
Thermal Resistance, Junction to Case (Note 6)	$R_{ heta JC}$	11		
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C	

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout. 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate. 7. I_{AR} and E_{AR} ratings are based on low frequency and duty cycles to keep $T_{J} = +25^{\circ}\text{C}$







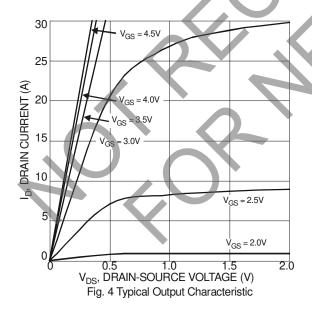


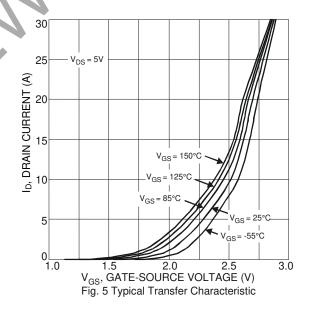


Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

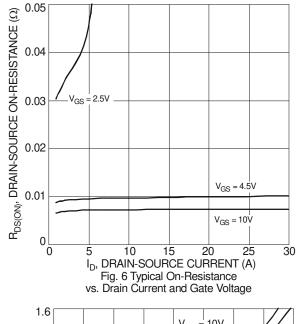
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)		•		•	•	
Drain-Source Breakdown Voltage	BV _{DSS}	30	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	-	-	100	μΑ	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	1.0	1.5	2.5	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance	D	-	7.3	10	mΩ	$V_{GS} = 10V, I_D = 13.5A$
Static Diani-Source On-nesistance	R _{DS (ON)}	-	10	15	11122	$V_{GS} = 4.5V, I_D = 11A$
Forward Transfer Admittance	Y _{fs}	-	22	-	S	$V_{DS} = 5V, I_{D} = 10.0A$
Diode Forward Voltage	V_{SD}	-	0.45	0.55	V	$V_{GS} = 0V, I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C _{iss}	-	1296	4310	pF	V
Output Capacitance	Coss	-	415	-	pF	$V_{DS} = 15V$, $V_{GS} = 0V$, $f = 1.0MHz$
Reverse Transfer Capacitance	C _{rss}	-	204	-	pF	1 = 1.0101112
Gate Resistance	R_{g}	0.26	1.6	2.7	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$
Total Gate Charge V _{GS} = 4.5V	Q_{g}	-	14.7	-	nC	
Total Gate Charge V _{GS} = 10V		-	31.6	-	nC	V 15V V 10V L 10.5A
Gate-Source Charge	Qgs	-	3.5	·	nC	$V_{DS} = 15V$, $V_{GS} = 10V$, $I_D = 13.5A$
Gate-Drain Charge	Q_{gd}	-	5.0	-	nC	
Turn-On Delay Time	t _{D(on)}	-	15.8	-	ns	
Turn-On Rise Time	t _r	-	27.8		ns	$V_{GS} = 10V, V_{DS} = 15V,$
Turn-Off Delay Time	t _{D(off)}	-	29.7	-	ns	$R_G = 3\Omega, I_D = 8.8A$
Turn-Off Fall Time	t _f	-	13.6		ns	
Reverse Recovery Time	t _{rr}	1	13.1		ns	I _F = 13.5A, di/dt = 100A/μs
Reverse Recovery Charge	Q _{rr}		4.3	-	nC	I _F = 13.5A, di/dt = 100A/μs

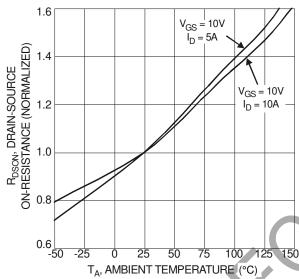
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing. Notes:

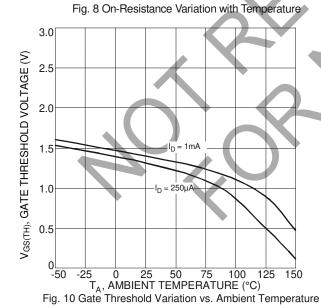


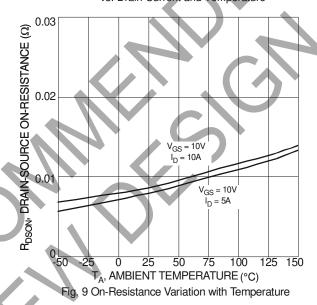


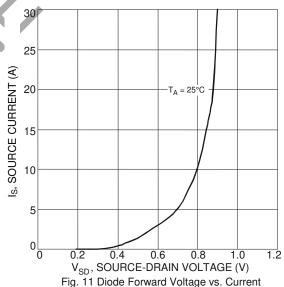




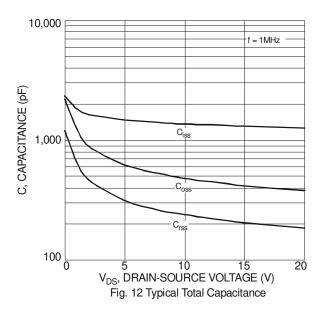


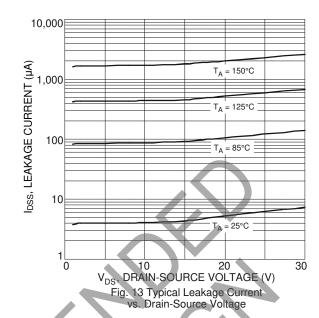


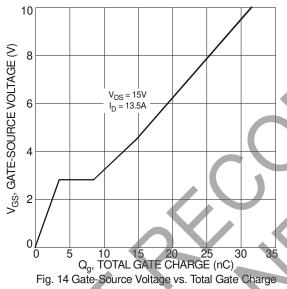








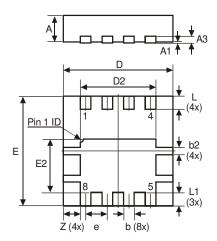






Package Outline Dimensions

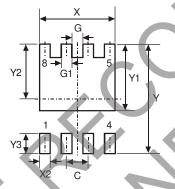
Please see http://www.diodes.com/package-outlines.html for the latest version.



PowerDI3333-8					
Dim	Min	Max	Тур		
D	3.25	3.35	3.30		
Е	3.25	3.35	3.30		
D2	2.22	2.32	2.27		
E2	1.56	1.66	1.61		
Α	0.75	0.85	0.80		
A1	0	0.05	0.02		
A3	_	_	0.203		
b	0.27	0.37	0.32		
b2	_	- <	0.20		
L	0.35	0.45	0.40		
L1	-		0.39		
е	=	-	0.65		
Z			0.515		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)			
С	0.650			
G	0.230			
G1	0.420			
Υ	3.700			
Y1	2.250			
Y2	1.850			
Y3	0.700			
Х	2.370			
٧o	0.420			



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DMG7702SFG

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